

Search Notes

Application/Control No.

09/621,400

Examiner

Susan Y. Chen

Applicant(s)/Patent under
Reexamination

DERE ET AL.

Art Unit

2161

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
707	104.1	11/19/2007	TYC
717	174	11/19/2007	TYC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated texts search on East DB for classes/subclasses: 707/10, 104.1; 717/174, 175; 715/501.1	11/19/2007	TYC
NPL-IEEE, Google, ACM	11/19/2007	TYC
Consult with class 717 primary examiner Tuan Vu for classes/subclasses cross-reference	11/16/2007	TYC